

Inventor Information

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Citizenship Country:: JAPAN

Correspondence Information

Correspondence Customer Number:: 25944

Application Information

Title Line One:: TEST METHOD OF ELECTRO-OPTICAL
Title Line Two:: DEVICE, TEST CIRCUIT OF ELECTRO-
Title Line Three:: OPTICAL DEVICE, ELECTRO-OPTICAL
Title Line Four:: DEVICE, AND ELECTRONIC EQUIPMENT
Total Drawing Sheets:: 10
Docket Number:: 110954

Prior Foreign Applications

Foreign Application One:: 2000-372839
Filing Date:: December 7, 2000
Country:: JAPAN
Priority Claimed:: YES

Assignee Information

Name of assignee:: SEIKO EPSON CORPORATION
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2000-372839